

Notice of References Cited	Application/Control No. 10/676,100	Applicant(s)/Patent Under Reexamination JEON ET AL.	
	Examiner Jeffrey S. Smith	Art Unit 2624	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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FOREIGN PATENT DOCUMENTS

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	N					
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	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	English language translation of Japanese application number 10-257084 entitled "Image Pickup Method and Device for Object with Periodic Contrast Pattern and Inspecting Method and Device Using These"
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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